Product Preview

Dual Boost Power Module

1200 V, 40 A IGBT with SiC Rectifier

The NXH80B120H2Q0SG is a power module containing a dual boost stage consisting of two 40 A / 1200 V IGBTs, two 15 A / 1200 V silicon carbide diodes, two 25 A / 1600 V anti–parallel diodes for the IGBTs and two 25 A / 1600 V bypass rectifiers. An on–board thermistor is included.

Features

- Dual Boost 40 A / 1200 V IGBT + SiC Rectifier Hybrid Module
- 25 A / 1600 V Bypass and Anti-parallel Diodes
- IGBT Specifications: $V_{CE(SAT)} = 2.2 \text{ V}$, $E_{SW} = 2180 \mu\text{J}$
- SiC Rectifier Specification: V_F = 1.4 V
- Solderable Pins
- Thermistor

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies

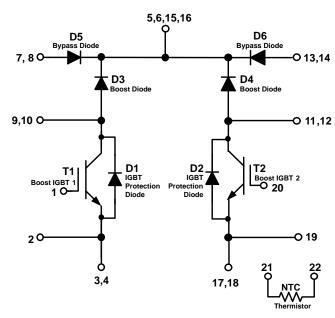


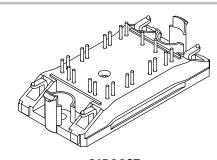
Figure 1. NXH80B120H2Q0SG Schematic Diagram

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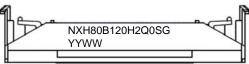
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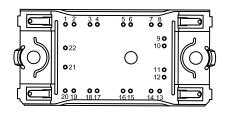
Q0BOOST CASE 180AJ

MARKING DIAGRAM



NXH80B120H2Q0SG = Specific Device Code YYWW = Year and Work Week Code

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

Table 1. ABSOLUTE MAXIMUM RATINGS (Note 1) $T_J = 25$ °C unless otherwise noted

Rating	Symbol	Value	Unit
BOOST IGBT			•
Collector–Emitter Voltage	V _{CES}	1200	V
Gate–Emitter Voltage	V_{GE}	±20	V
Continuous Collector Current @ T _h = 80°C (T _J = 175°C)	I _C	41	А
Pulsed Collector Current (T _J = 175°C)	I _{Cpulse}	123	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	103	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 600 V, $T_{J} \le 150^{\circ}C$	T _{sc}	5	μs
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
BOOST DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Continuous Forward Current @ T _h = 80°C (T _J = 175°C)	I _F	24	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	79	W
Surge Forward Current (60 Hz single half–sine wave)	I _{FSM}	69	А
I ² t – value (60 Hz single half–sine wave)	I ² t	19	A ² s
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
BYPASS DIODE / IGBT PROTECTION DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	1600	V
Continuous Forward Current @ T _h = 80°C (T _J = 175°C)	I _F	46	А
Repetitive Peak Forward Current (T _J = 175°C, t _p limited by T _{Jmax})	I _{FRM}	130	А
Power Dissipation Per Diode (T _J = 175°C)	P _{tot}	66	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
THERMAL PROPERTIES			•
Storage Temperature range	T _{stg}	-40 to 125	°C
INSULATION PROPERTIES	•		•
Isolation test voltage, t = 1 sec, 60 Hz	V _{is}	3000	V _{RMS}
Creepage distance		12.7	mm
			_

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality

Table 2. RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	-40	(T _{jmax} -25)	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

Table 3. ELECTRICAL CHARACTERISTICS $T_J = 25$ °C unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
BOOST IGBT CHARACTERISTICS						
Collector–Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1200 V	I _{CES}	-	_	200	μΑ
Collector-Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 40 A, T _J = 25°C	V _{CE(sat)}	-	2.20	2.5	V
	V _{GE} = 15 V, I _C = 40 A, T _J = 150°C		-	2.16	-	
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 1.5 \text{ mA}$	V _{GE(TH)}	-	5.45	6.4	V
Gate Leakage Current	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	_	-	200	nA
Turn-on Delay Time	T _J = 25°C	t _{d(on)}	-	27	_	ns
Rise Time	$V_{CE} = 700 \text{ V}, I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_{G} = 4 \Omega$	t _r	-	19	_	
Turn-off Delay Time	GL - , G	t _{d(off)}	-	94	_	
Fall Time	7	t _f	-	78	_	
Turn-on Switching Loss per Pulse	7	Eon	-	540	_	μJ
Turn-off Switching Loss per Pulse	7	E _{off}	-	1640	_	
Turn-on Delay Time	T _J = 125°C	t _{d(on)}	-	27	_	ns
Rise Time	$V_{CE} = 700 \text{ V, } I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V, } R_{G} = 4 \Omega$	t _r	_	20	_	
Turn-off Delay Time	VGE = ±10 V, NG = 122	t _{d(off)}	_	110	_	
Fall Time	7	t _f	_	189	_	
Turn-on Switching Loss per Pulse	7	E _{on}	-	620	_	μJ
Turn-off Switching Loss per Pulse	7	E _{off}	-	3590	_	
Input Capacitance	V _{CE} = 25 V, V _{GE} = 0 V, f = 10 kHz	C _{ies}	-	9700	-	pF
Output Capacitance	7	C _{oes}	-	200	_	1
Reverse Transfer Capacitance	7	C _{res}	-	170	_	
Total Gate Charge	V _{CE} = 600 V, I _C = 40 A, V _{GE} = 15 V	Qg	_	400	_	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness < 100 μ m, λ = 0.84 W/mK	R _{thJH}	_	0.92	_	°C/W
BOOST DIODE CHARACTERISTICS					1	
Diode Reverse Leakage Current	V _R = 1200 V	I _R	_	_	300	μΑ
Diode Forward Voltage	I _F = 15 A, T _J = 25°C	V _F	_	1.42	1.7	V
	I _F = 15 A, T _J = 150°C		-	1.95	_	
Reverse Recovery Time	T _J = 25°C	t _{rr}	-	27	_	ns
Reverse Recovery Charge	$V_{CE} = 700 \text{ V}, I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_{G} = 4 \Omega$	Q _{rr}	-	280	_	nC
Peak Reverse Recovery Current	VGE - ±13 V, NG - 4 52	I _{RRM}	-	16	_	Α
Peak Rate of Fall of Recovery Current	7	di/dt	-	1080	_	A/μs
Reverse Recovery Energy	7	E _{rr}	-	130	_	μJ
Reverse Recovery Time	T _J = 125°C	t _{rr}	_	28	_	ns
Reverse Recovery Charge	$V_{CE} = 700 \text{ V}, I_{C} = 40 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_{G} = 4 \Omega$	Q _{rr}	_	250	_	nC
Peak Reverse Recovery Current	VGE = ±13 V, NG = 4 52	I _{RRM}	_	15	_	Α
Peak Rate of Fall of Recovery Current	7	di/dt	_	940	_	A/μs
Reverse Recovery Energy	1	E _{rr}	_	110	_	μJ
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness < 100 μ m, λ = 0.84 W/mK	R _{thJH}	_	1.21	-	°C/W
BYPASS DIODE/IGBT PROTECTION DIO	DE CHARACTERISTICS	•		•	•	•
Diode Reverse Leakage Current	V _R = 1600 V, T _J = 25°C	I _R	_	_	100	μА

Table 3. ELECTRICAL CHARACTERISTICS T. = 25°C unless otherwise noted

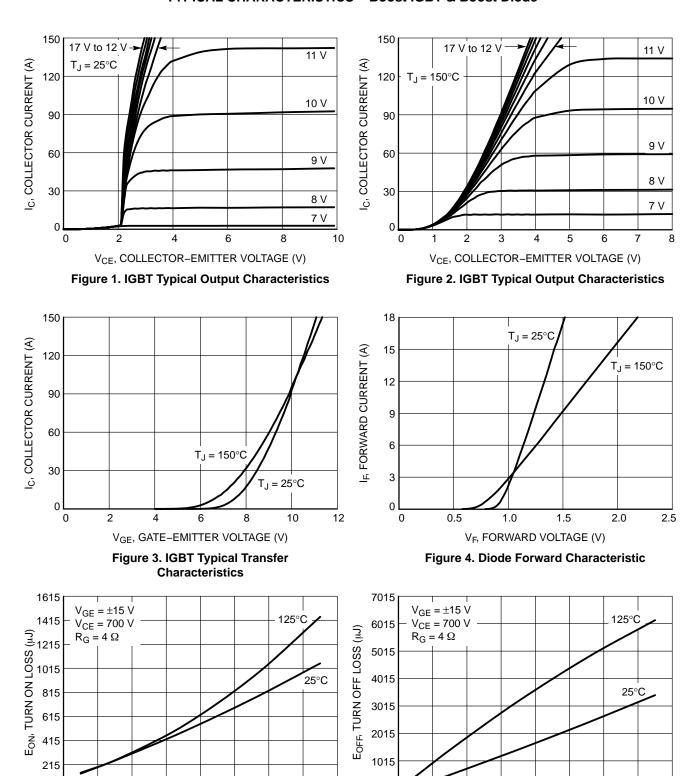
Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
BYPASS DIODE/IGBT PROTECTION DIO	DE CHARACTERISTICS				•	
Diode Forward Voltage	I _F = 25 A, T _J = 25°C	V_{F}	-	1.0 0.90	1.4	V
	I _F = 25 A, T _J = 150°C		-			
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness < 100 μm, λ = 0.84 W/mK	R _{thJH}	-	1.44	-	°C/W
THERMISTOR CHARACTERISTICS					•	
Nominal resistance		R ₂₅	-	22	_	kΩ
Nominal resistance	T = 100°C	R ₁₀₀	-	1486	-	Ω
Deviation of R25		ΔR/R	-5	_	5	%
Power dissipation		P _D	-	200	-	mW
Power dissipation constant			-	2	-	mW/K
B-value	B(25/50), tolerance ±3% – 3950		_	K		
B-value	B(25/100), tolerance ±3%		_	3998	_	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH80B120H2Q0SG Q0BOOST	NXH80B120H2Q0SG	Q0BOOST – Case 180AJ (Pb–Free and Halide–Free Solder Pins)	24 Units / Blister Tray

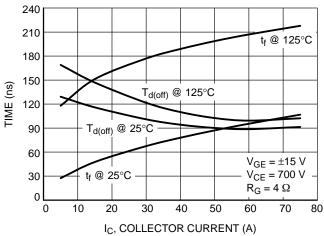
TYPICAL CHARACTERISTICS - Boost IGBT & Boost Diode



 $\label{eq:lc} I_C, COLLECTOR \ CURRENT \ (A)$ Figure 5. Typical Turn On Loss vs. IC

 $\label{eq:collector} I_C, \mbox{ COLLECTOR CURRENT (A)}$ Figure 6. Typical Turn Off Loss vs. IC

TYPICAL CHARACTERISTICS - Boost IGBT & Boost Diode



I_C, COLLECTOR CURRENT (A)

Figure 7. Typical Switching Times vs. IC

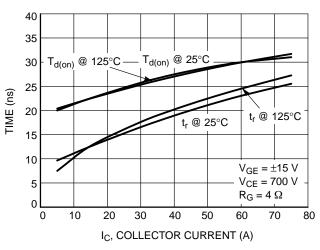


Figure 8. Typical Switching Times vs. IC

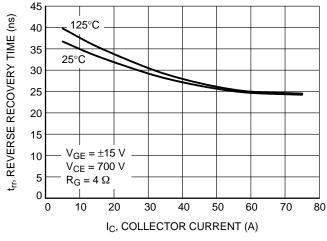


Figure 9. Typical Reverse Recovery Time vs. IC

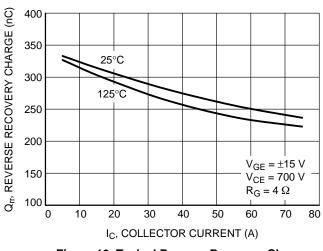


Figure 10. Typical Reverse Recovery Charge vs. IC

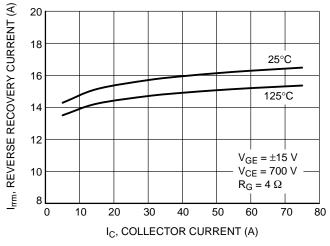


Figure 11. Typical Reverse Recovery Peak
Current vs. IC

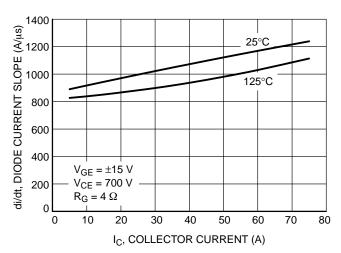
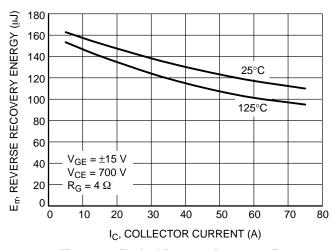


Figure 12. Typical Diode Current Slope vs. IC

TYPICAL CHARACTERISTICS - Boost IGBT & Boost Diode



16 V_{CE} = 600 V 14 $I_{C} = 40 \text{ A}$ V_{GE}, GATE VOLTAGE (V) 12 10 8 6 4 2 0 100 200 300 400 500 0 Q_G, GATE CHARGE (nC)

Figure 13. Typical Reverse Recovery Energy vs. IC

Figure 14. Gate Voltage vs. Gate Charge

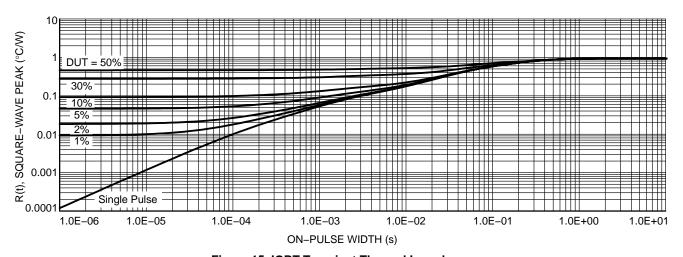


Figure 15. IGBT Transient Thermal Impedance

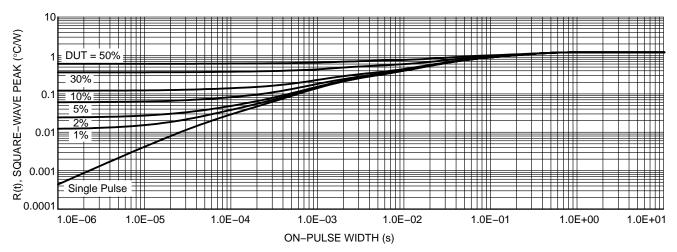


Figure 16. Diode Transient Thermal Impedance

TYPICAL CHARACTERISTICS - IGBT Protection Diode and Bypass Diode

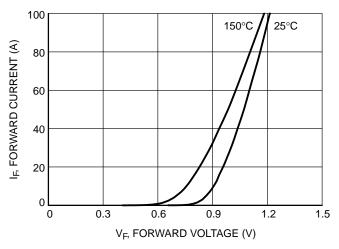


Figure 17. Diode Forward Characteristic

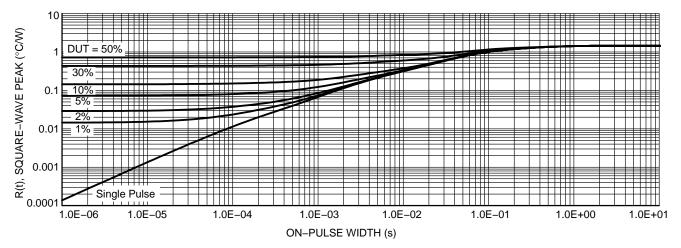


Figure 18. Diode Transient Thermal Impedance

TYPICAL CHARACTERISTICS – Thermistor

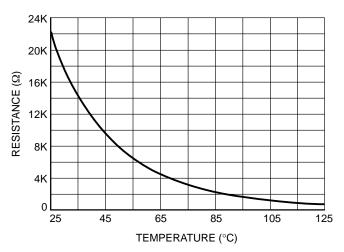
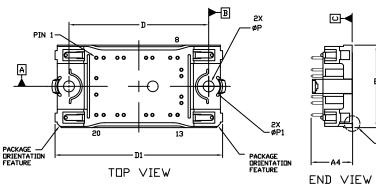


Figure 19. Thermistor Characteristic

PACKAGE DIMENSIONS

PIM22, 55x32.5 / Q0BOOST

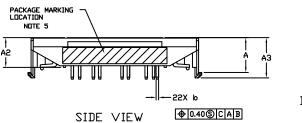
CASE 180AJ ISSUE A





NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION 6 APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
- 4. POSITION OF THE CENTER OF THE TERMINALS
 IS DETERMINED FROM DATUM B THE CENTER OF
 DIMENSION D, X DIRECTION, AND FROM DATUM A,
 Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED
 IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH
 DIRECTIONS.
 - 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.





NOTE 4

	PIN P	NOITIZE		PIN PI	NDITIZE
PIN	х	Υ	PIN	х	Y
1	-16.75	11.25	12	16.75	-6.55
2	-13.85	11.25	13	15.25	-11.25
3	-8.45	11.25	14	12.35	-11.25
4	-5.95	11.25	15	5.35	-11.25
5	2.85	11.25	16	2.85	-11.25
6	5.35	11.25	17	-5.95	-11.25
7	12.35	11.25	18	-8.45	-11.25
8	15.25	11.25	19	-13.85	-11.25
9	16.75	6.55	20	-16.75	-11.25
10	16.75	4.05	21	-16.75	-3.25
11	16.75	-4.05	22	-16.75	3.25

	MILLIMETERS			
DIM	MIN.	NDM.		
Α	13.50	13.90		
A1	0.10	0.30		
A2	11.50	11.90		
A3	15.65	16.05		
A4	16.35 REF			
b	0.95	1.05		
D	54.80	55.20		
D1	65.60	66.20		
Ε	32.20 32.80			
Р	4.20	4.40		
P1	8.90	9.10		

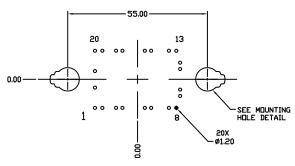
PACKAGE DIMENSIONS

PIM22, 55x32.5 / Q0BOOST

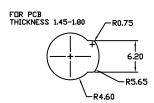
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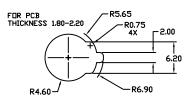
MOUNTING HOLE POSITION

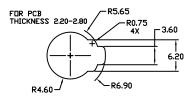
	HOLE P	NDITIZO		PIN P	NDITIZE
PIN	Х	7	PIN	х	Υ
1	-16.75	-11.25	12	16.75	6.55
2	-13.85	-11.25	13	15.25	11.25
3	-8.45	-11.25	14	12.35	11.25
4	-5.95	-11.25	15	5.35	11.25
5	2.85	-11.25	16	2.85	11.25
6	5.35	-11.25	17	-5.95	11.25
7	12.35	-11.25	18	-8.45	11.25
8	15.25	-11.25	19	-13.85	11.25
9	16.75	-6.55	20	-16.75	11.25
10	16.75	-4.05	21	-16.75	3.25
11	16.75	4.05	22	-16.75	-3.25



RECOMMENDED MOUNTING PATTERN







MOUNTING HOLE DETAIL

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